

●General Description

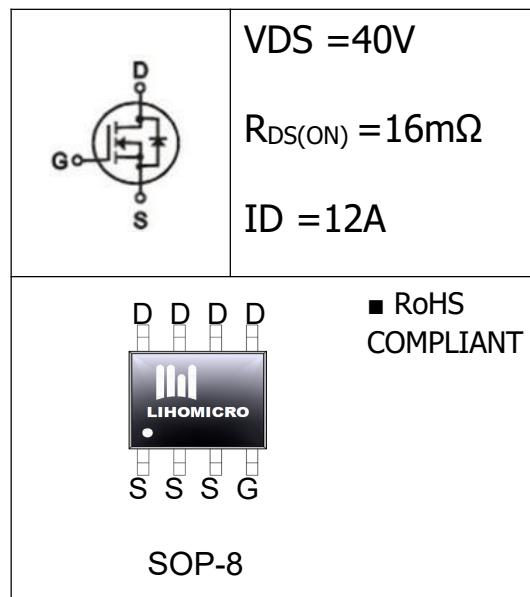
The N-Channel MOSFET LH12N04 has the low $R_{DS(on)}$, low gate charge, fast switching and excellent avalanche characteristics. This device is suitable for fast charge and lighting.

●Features

- Advance high cell density Trench technology
- Low RDS(ON) to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

●Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- BLDC Motor driver
- POL application



●Ordering Information:

Part Number	LH12N04
Package	SOP-8
Basic Ordering Unit (pcs)	4000
Normal Package Material Ordering Code	LH12N04S-SOP8-TAP
Halogen Free Ordering Code	LH12N04S-SOP8-TAP-HF

●Absolute Maximum Ratings (TC = 25°C)

PARAMETER	SYMBOL	Value	UNIT
Drain-Source Breakdown Voltage	BV _{DSS}	40	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current @TA=25°C	I _D	12	A
Pulsed drain current ¹	I _{DM}	60	A
Avalanche Energy	E _{AS}	30	mJ
Power Dissipation ²	P _D	60	W
Power Dissipation @TA=25°C		2.0	
Operating Temperature	T _J	-55~+150	°C
Storage Temperature	T _{STG}	-55~+150	°C

•Electronic Characteristics

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	40	--	--	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	--	3.0	V
Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=7A$	--	13	16	$m\Omega$
		$V_{GS}=4.5V, I_D=6A$	--	18	25	
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=40V, V_{GS}=0V, T_J=25^\circ C$	--	--	1	μA
Gate-to-Source Leakage Current	I_{GSS}	$V_{GS}=+20V, V_{DS}=0V$	--	--	+100	nA
Diode Forward Voltage	V_{sd}	$V_{DS}=0V, I_{DS}=1.8A$	--	0.8	1.2	V
Input Capacitance	C_{iss}	$f=1MHz$	--	884	--	pF
Output Capacitance	C_{oss}		--	124	--	
Reverse Transfer Capacitance	C_{rss}		--	39	--	
Total Gate Charge(10V)	Q_g	$V_{GS}=4.5V, V_{DS}=20V, I_D=5.7A$	--	11	--	nC
Gate-to-Source Charge	Q_{gs}		--	4.9	--	
Gate-to-Drain Charge	Q_{gd}		--	4.7	--	

•Thermal Characteristics

PARAMETER	SYMBOL	MAX	UNIT
Thermal Resistance Junction-case ²	R_{thJC}	1.5	$^\circ C/W$
Thermal Resistance Junction-ambient	R_{thJA}	62.5	$^\circ C/W$
Soldering temperature, wavesoldering for 10s	T_{sold}	265	$^\circ C$

Notes:

1.Pulse Test : Pulse width $\leqslant 300 \mu s$, Duty cycle $\leqslant 2\%$;

2.Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

•Typical Characteristics

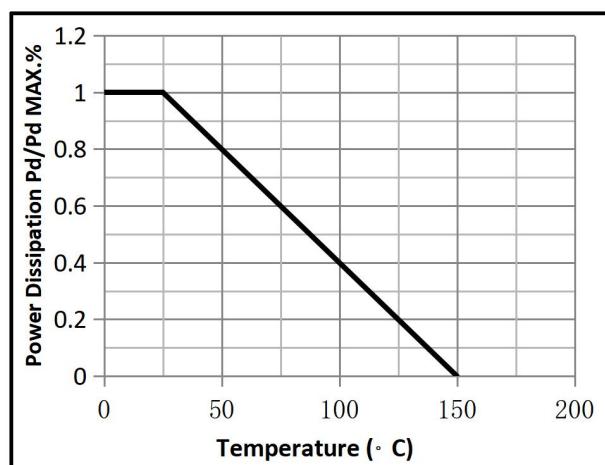


Fig.1 Power Dissipation

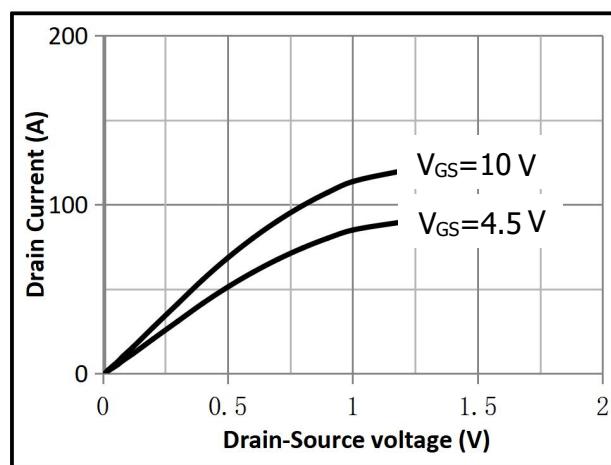


Fig.2 Typical output Characteristics

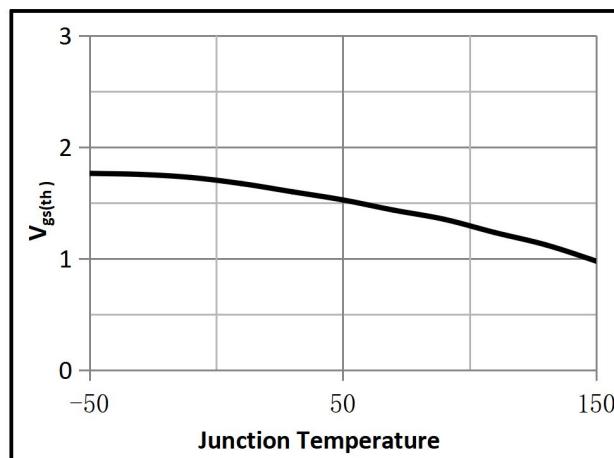


Fig.3 Threshold Voltage V.S Junction Temperature

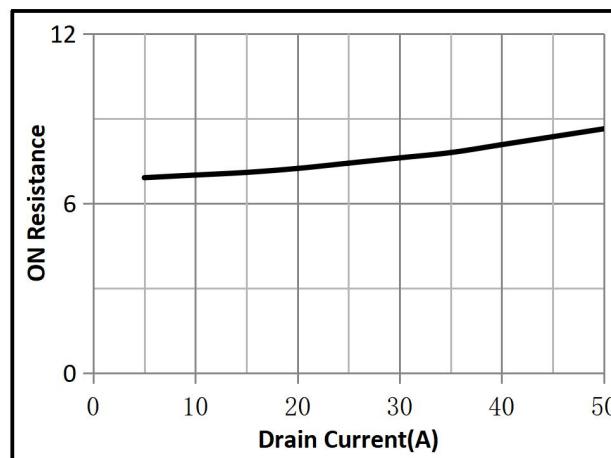


Fig.4 Resistance V.S Drain Current

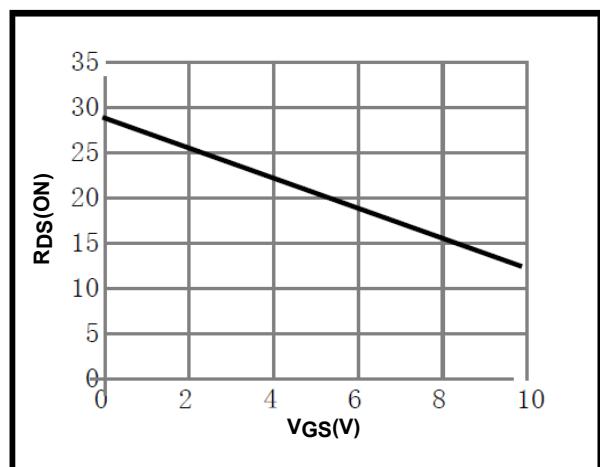


Fig.5 On-Resistance VS Gate Source Voltage

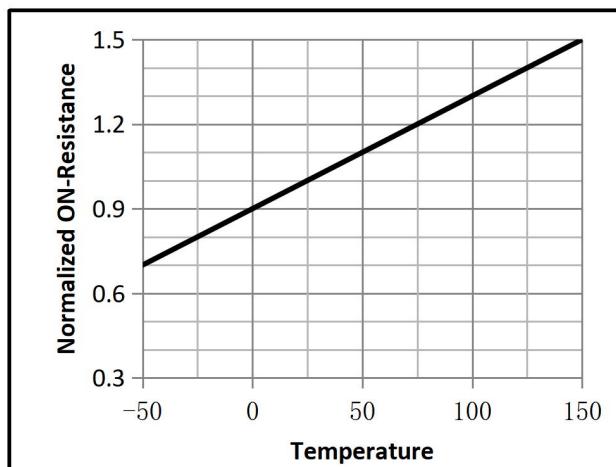


Fig.6 On-Resistance V.S Junction Temperature

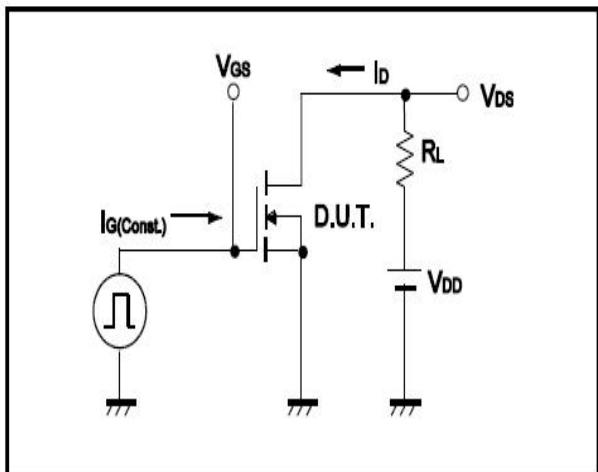
•Typical Characteristics(cont.)


Fig.7 Switching Time Measurement Circuit

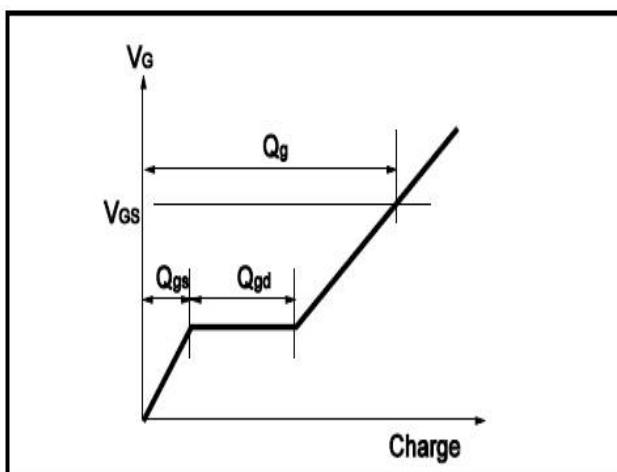


Fig.8 Gate Charge Waveform

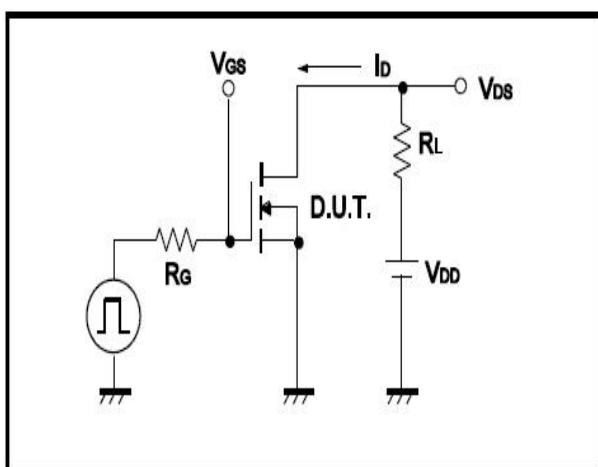


Fig.9 Switching Time Measurement Circuit

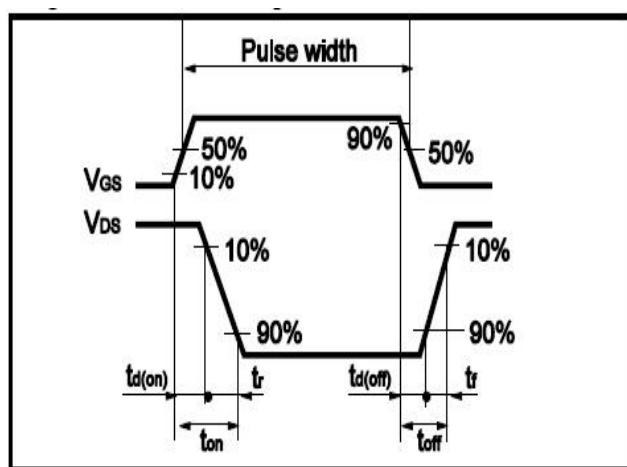


Fig.10 Gate Charge Waveform

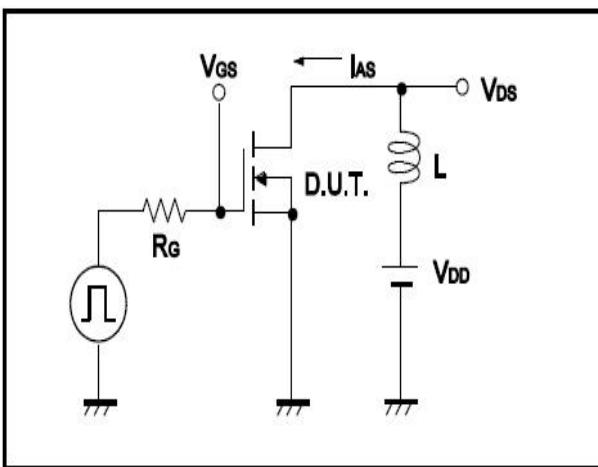


Fig.11 Avalanche Measurement Circuit

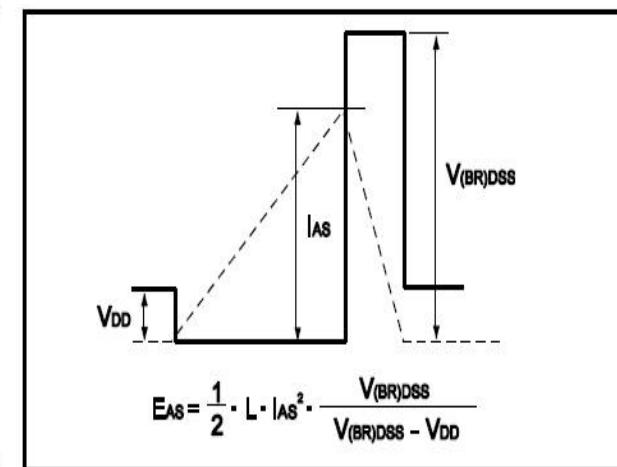


Fig.12 Avalanche Waveform

•Dimensions (SOP-8)

UNIT:mm

SYMBOL	min	max	SYMBOL	min	max
A	1.30	1.60	e	1.27BSC	
A1	1.35	1.85	L	0.40	1.30
b	0.30	0.60			
C	0.15	0.35			
D	4.60	5.20			
E	3.70	4.10			
E1	5.70	6.30			

